

■ DESCRIPTION

The STN2302 is the N-Channel logic enhancement mode power field effect transistor is produced using high cell density advanced trench technology to provide excellent $R_{DS(ON)}$, low gate charge and operation gate as 1.8V. This device is suitable for use as a load switch or other general applications.

STN2302S-TRG ROHS Compliant This is Halogen Free

20V N-Channel Enhancement Mode MOSFET

■ FEATURE

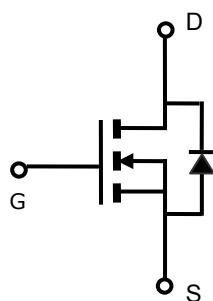
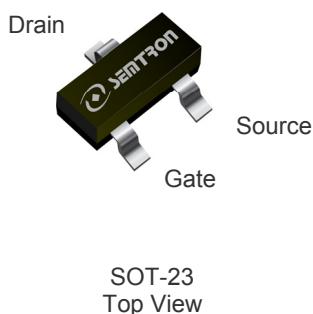
- ◆ 20V/4.0A, $R_{DS(ON)} = 50m\Omega$ (typ.)@ $V_{GS} = 4.5V$
- ◆ 20V/3.0A, $R_{DS(ON)} = 65m\Omega$ (typ.)@ $V_{GS} = 2.5V$
- ◆ Super high density cell design for extremely low Gate Charge
- ◆ Exceptional on-resistance and Maximum DC current capability

■ APPLICATIONS

- ◆ Power Management in Note book
- ◆ Portable Equipment
- ◆ Load Switch



■ PIN CONFIGURATION



■ PART NUMBER INFORMATION

ST N 2302 S - TR G
 a b c d e f

a : Company name.
 b : Channel type.
 c : Product Serial number.
 d : Package code
 e : Handling code
 f : Green product code

■ ORDERING INFORMATION

Part Number	Package Code	Handling Code	Shipping
STN2302S-TRG	S : SOT-23	TR : Tape&Reel	3K/Reel

※ Year Code : 0 ~ 9, 2010 : 0

※ Week Code : A(1~2) ~ Z(53~54)

※ SOT-23 : Only available in tape and reel packaging.

■ ABSOLUTE MAXIMUM RATINGS ($T_A = 25^\circ\text{C}$ Unless otherwise noted)

Symbol	Parameter	Typical	Unit
V_{DSS}	Drain-Source Voltage	20	V
V_{GSS}	Gate-Source Voltage	± 12	V
I_D	Continuous Drain Current ($T_c=25^\circ\text{C}$) ^A	4.6	A
	Continuous Drain Current ($T_c=70^\circ\text{C}$) ^A		
I_{DM}	Pulsed Drain Current ^B	14	A
P_D	Power Dissipation	$T_A=25^\circ\text{C}$ $T_A=70^\circ\text{C}$	1.0 0.7
T_J	Operation Junction Temperature	-55 to 150	$^\circ\text{C}$
T_{STG}	Storage Temperature Range	-55 to 150	$^\circ\text{C}$

Note: Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

■ THERMAL DATA

Symbol	Parameter	Typ	Max	Unit
$R_{\theta JA}$	Thermal Resistance-Junction to Ambient ^A	Steady-State	-	$^\circ\text{C}/\text{W}$
$R_{\theta JC}$	Thermal Resistance Junction to Lead ^A	Steady-State	-	$^\circ\text{C}/\text{W}$

ELECTRICAL CHARACTERISTICS($T_A = 25^\circ\text{C}$ Unless otherwise noted)

Symbol	Parameter	Condition	Min	Typ	Max	Unit	
Static Parameters							
$V_{(\text{BR})\text{DSS}}$	Drain-Source Breakdown Voltage	$V_{GS}=0\text{V}, I_D=250\mu\text{A}$	20			V	
$V_{GS(\text{th})}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=250\mu\text{A}$	0.5		1.0	V	
I_{GSS}	Gate Leakage Current	$V_{DS}=0\text{V}, V_{GS}=\pm 12\text{V}$			± 100	nA	
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS}=20\text{V}, V_{GS}=0\text{V}$			1	μA	
		$V_{DS}=20\text{V}, V_{GS}=0\text{V}$ $T_J=55^\circ\text{C}$			5		
$R_{DS(\text{ON})}$	Drain-source On-Resistance ^B	$V_{GS}=4.5\text{V}, I_D=4.0\text{A}$ $V_{GS}=2.5\text{V}, I_D=3.0\text{A}$		40 54	50 75	$\text{m}\Omega$	
G_f	Forward Transconductance	$V_{DS}=5\text{V}, I_D=3\text{A}$		10.5		S	
Source-Drain Diode							
V_{SD}	Diode Forward Voltage	$I_S=1.0\text{A}, V_{GS}=0\text{V}$		0.7	1.2	V	
I_S	Continuous Source Current ^{AD}				3.6	A	
Dynamic Parameters							
Q_g	Total Gate Charge	$V_{DS}=10\text{V}$ $V_{GS}=4.5\text{V}$ $I_D=3.0\text{A}$		4.7	6.6	nC	
Q_{gs}	Gate-Source Charge			0.68	0.96		
Q_{gd}	Gate-Drain Charge			1.3	1.8		
C_{iss}	Input Capacitance	$V_{DS}=15\text{V}$ $V_{GS}=0\text{V}$ $f=1\text{MHz}$		296	415	pF	
C_{oss}	Output Capacitance			44	62		
C_{rss}	Reverse Transfer Capacitance			35	49		
$t_{d(on)}$	Turn-On Time	$V_{DD}=10\text{V}$ $I_D=3.0\text{A}$ $V_{GEN}=4.5\text{V}$ $R_G=3.3\Omega$		1.4	2.8	nS	
t_r				40	72		
$t_{d(off)}$	Turn-Off Time			12.4	25		
t_f				5.6	11		

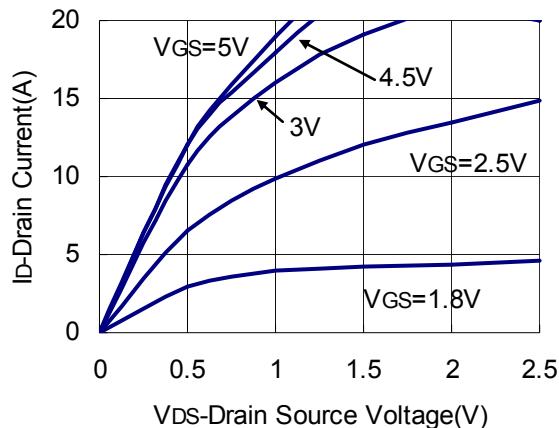
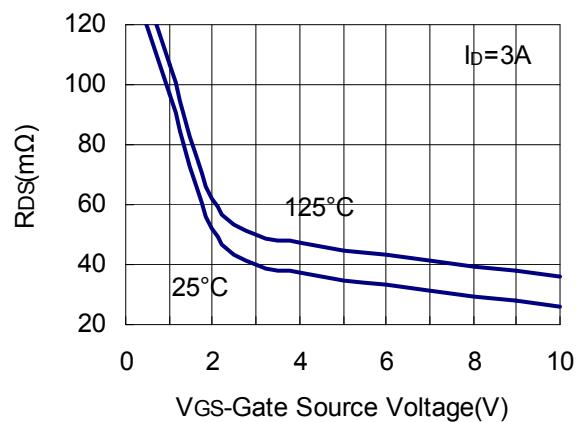
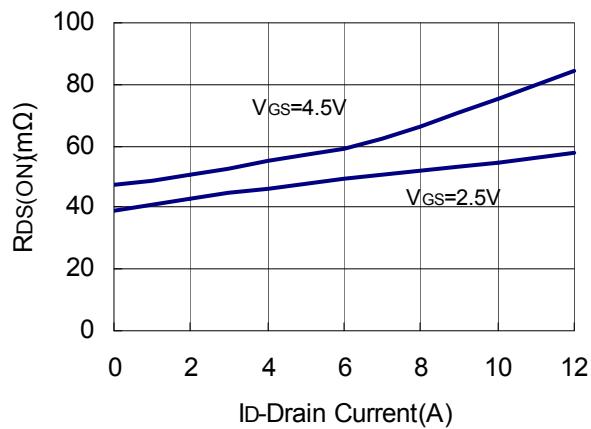
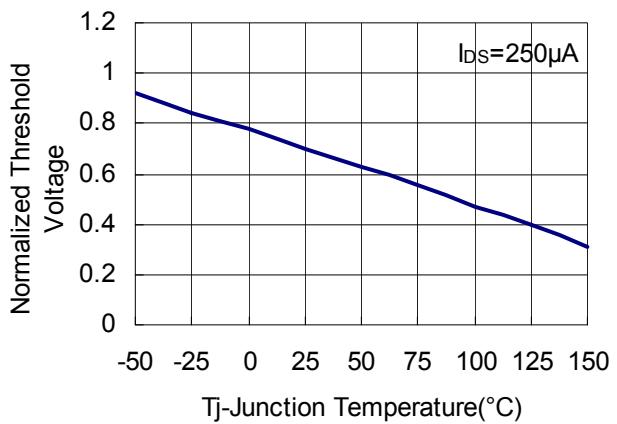
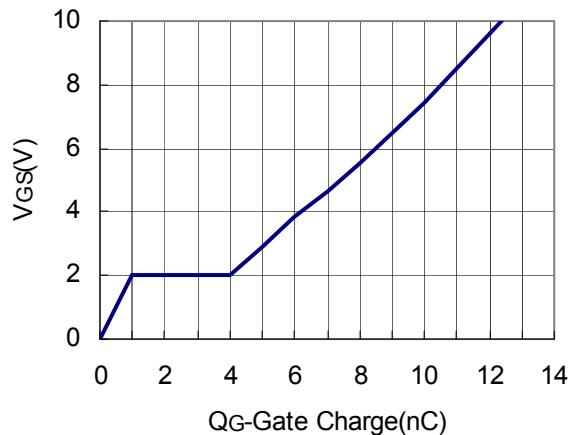
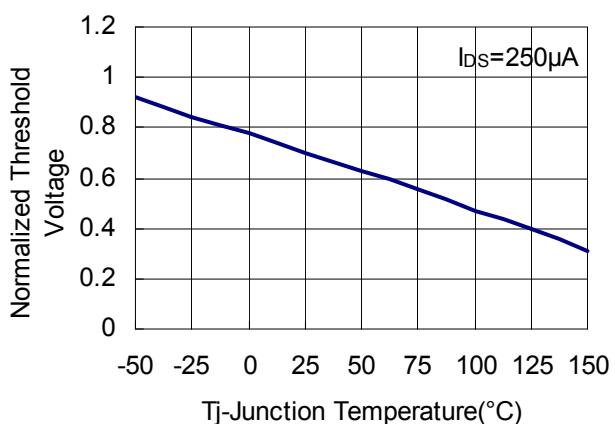
Note:

- A. The value of $R_{\theta JA}$ is measured with the device mounted on 1in 2 FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^\circ\text{C}$.
- B. The data tested by pulsed , pulse width $\leq 300\mu\text{s}$, duty cycle $\leq 2\%$
- C. The EAS data shows Max. rating . The test condition is $V_{DD}=-25\text{V}, V_{GS}=-10\text{V}, L=0.1\text{mH}$.
- D. The data is theoretically the same as I_D and I_{DM} , in real applications , should be limited by total power dissipation.

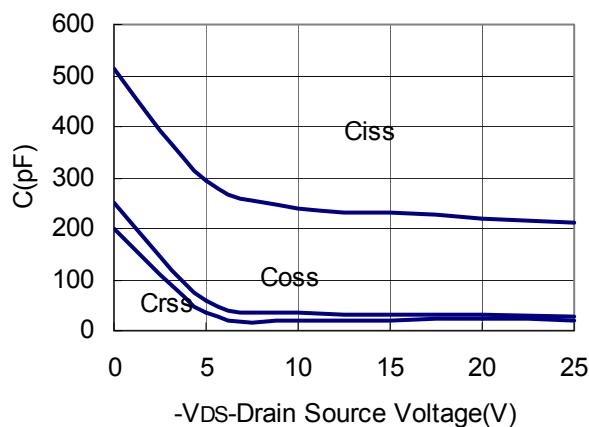
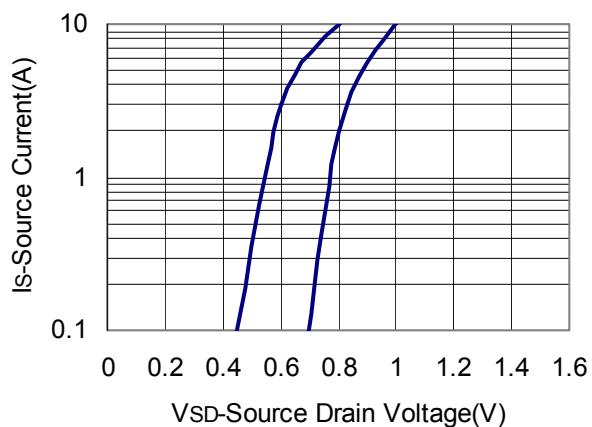
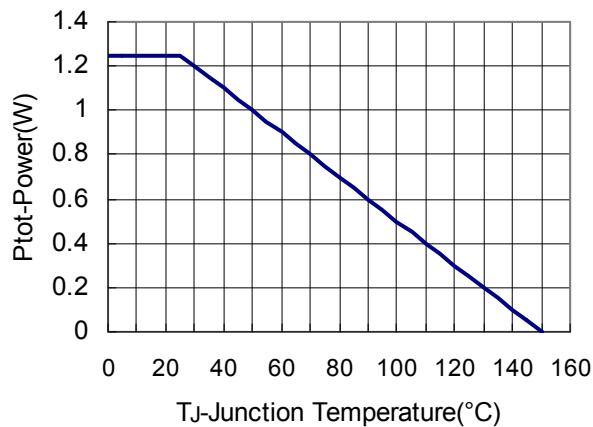
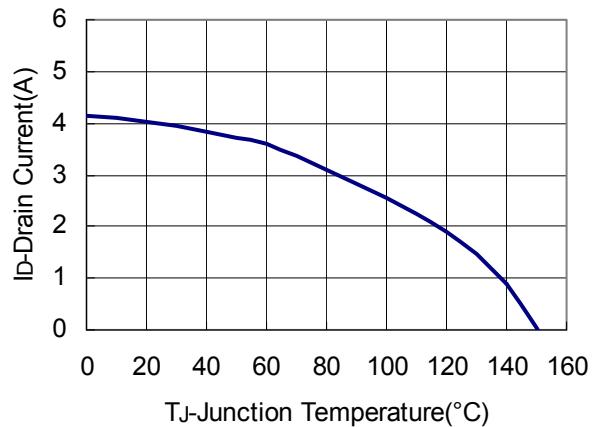
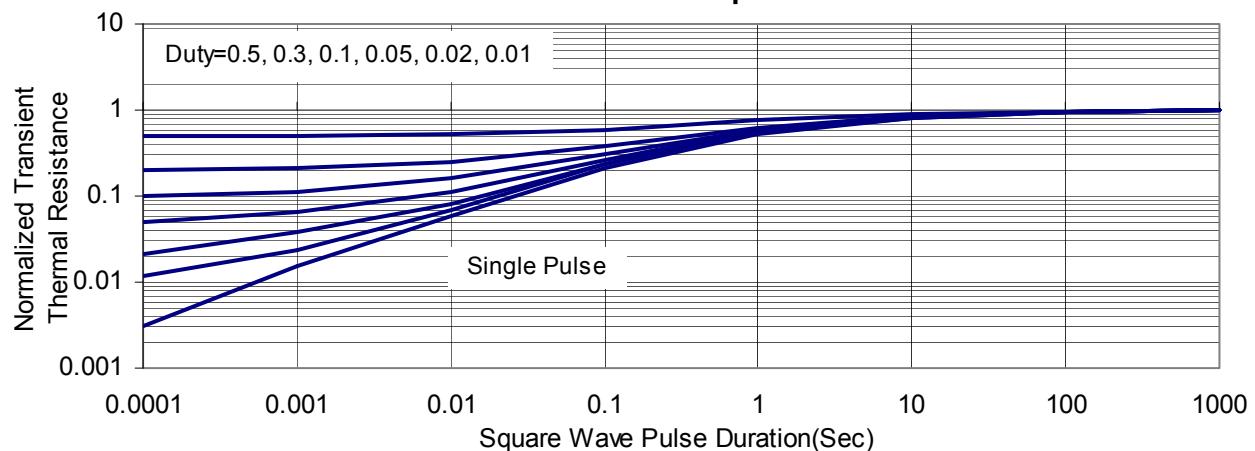
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TYPICAL CHARACTERISTICS

Output Characteristics

Drain-Source On Resistance

Drain Source On Resistance

Gate Threshold Voltage

Gate Charge

Gate Threshold Voltage


■ TYPICAL CHARACTERISTICS

Capacitance

Source Drain Diode Forward

Power Dissipation

Drain Current

Thermal Transient Impedance


SOT-23 PACKAGE DIMENSIONS

Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	0.900	1.150	0.035	0.045
A1	0.000	0.100	0.000	0.004
A2	0.900	1.050	0.035	0.041
b	0.300	0.500	0.012	0.020
c	0.080	0.150	0.003	0.006
D	2.800	3.000	0.110	0.118
E	1.200	1.400	0.047	0.055
E1	2.250	2.550	0.089	0.100
e	0.950 TYP.		0.037 TYP	
e1	1.800	2.000	0.071	0.079
L1	0.550 REF.		0.022 REF.	
L1	0.300	0.500	0.012	0.020
θ	0°	8°	0°	8°

